

Search Notes

Application/Control No.

09/877,210

Examiner

Yixing Qin

Applicant(s)/Patent under
Reexamination

ONISHI ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Looked over references previously found in the first search and found relevant art	7/8/2005	YQ